

**Notice of References Cited**

Application/Control No.

10/814,697

Applicant(s)/Patent Under  
Reexamination  
SHI ET AL.

Examiner

ANNA L. VERDERAME

Art Unit

1795

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**U.S. PATENT DOCUMENTS**

*		Document Number	Date	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY		
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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